

# MOSFET - Power, Single N-Channel, SO-8FL 30 V, 0.9 mΩ, 303 A

# NTMFS4C01N

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Paran	neter		Symbol	Value	Unit
Drain-to-Source Voltage		$V_{DSS}$	30	V	
Gate-to-Source Voltage	ate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	303	Α
Power Dissipation R <sub>θJC</sub> (Notes 1, 3)	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	134	W
Continuous Drain Current R <sub>0JA</sub> (Notes 1, 2, 3)	Steady State	T <sub>A</sub> = 25°C	_D	47	NA
Power Dissipation R <sub>θJA</sub> (Notes 1, 2, 3)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.2	(
Pulsed Drain Current	nt $T_A = 25^{\circ}C$ , $t_p = 10 \mu s$ $I_{DM}$			552	Α
Operating Junction and Storage Temperature T <sub>J</sub> , T <sub>stg</sub> , Range			T <sub>J</sub> , T <sub>stg</sub>	−55 to +150	°C
Source Current (Body Diode)		Js N	110	Α	
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 35 A)			EAS	862	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

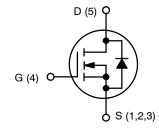
#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.93	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

1

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	0.9 m $\Omega$ @ 10 V	000 4
30 V	1.2 mΩ @ 4.5 V	303 A



**N-CHANNEL MOSFET** 



A = Assembly Location Y = Year

W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4C01NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4C01NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

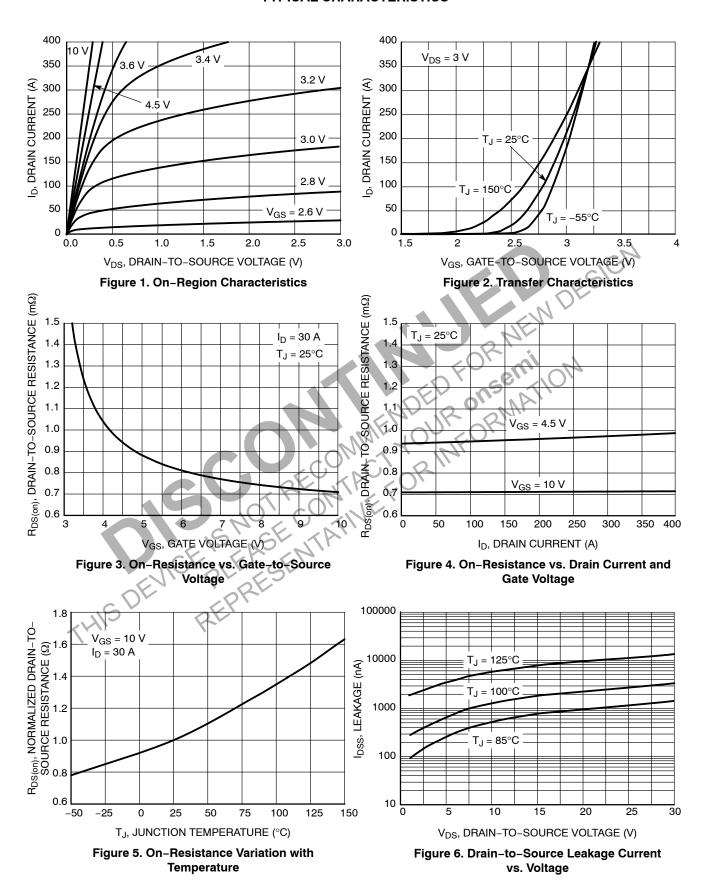
Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> =	= 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				16.3		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			1	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.3		2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.8		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		0.71	0.9	_
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		0.94	1.2	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 3 V	I <sub>D</sub> = 30 A		183	5	S
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25	°C		1.0		Ω
CHARGES AND CAPACITANCES				IN.	4		
Input Capacitance	C <sub>ISS</sub>		0	1	10144		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MH	z, V <sub>DS</sub> = 15 V	m'	5073		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>		0 05	31/	148		
Total Gate Charge	Q <sub>G(TOT)</sub>	101	000	Vb,	63		
Threshold Gate Charge	Q <sub>G(TH)</sub>	NERGY	UK OR		18		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			29		nC
Gate-to-Drain Charge	Q <sub>GD</sub>	0,0	11.		13		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 30 \text{ A}$			139		nC
SWITCHING CHARACTERISTICS (Note 5)	) / (	1/1/					
Turn-On Delay Time	t <sub>d(ON)</sub>	<i>y</i> ,			29		
Rise Time	tr	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 1	5 V, I <sub>D</sub> = 15 A,		68		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_{\rm G} = 3.0 \Omega$			53		ns
Fall Time	t <sub>f</sub>				36		
DRAIN-SOURCE DIODE CHARACTERISTIC	s	•					
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.73	1.1	
		I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.55		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dI}_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 30 \text{ A}$			87		
Charge Time	ta				43		ns
Discharge Time	t <sub>b</sub>				44		
Reverse Recovery Charge	Q <sub>RR</sub>				147		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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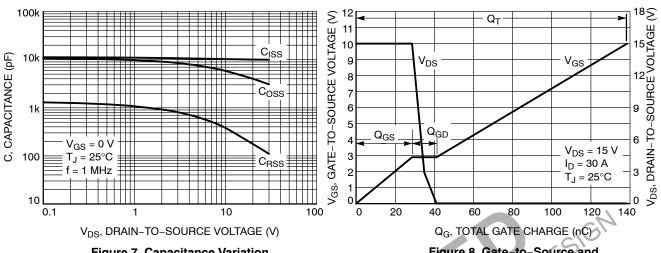


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

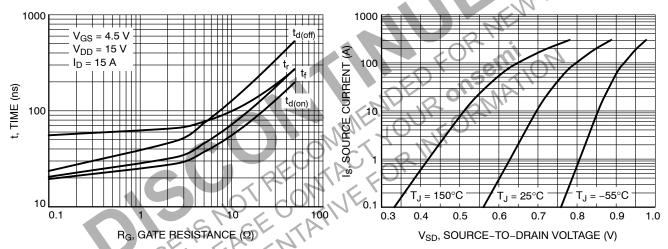


Figure 9. Resistive Switching Time Variation

Figure 10. Diode Forward Voltage vs. Current

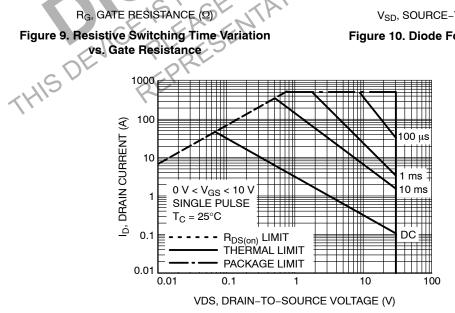


Figure 11. Maximum Rated Forward Biased **Safe Operating Area** 

#### **TYPICAL CHARACTERISTICS**

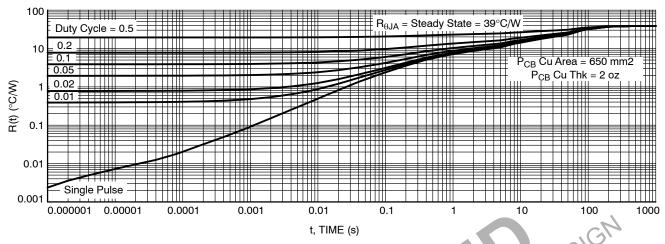


Figure 12. Thermal Impedance (Junction-to-Ambient)

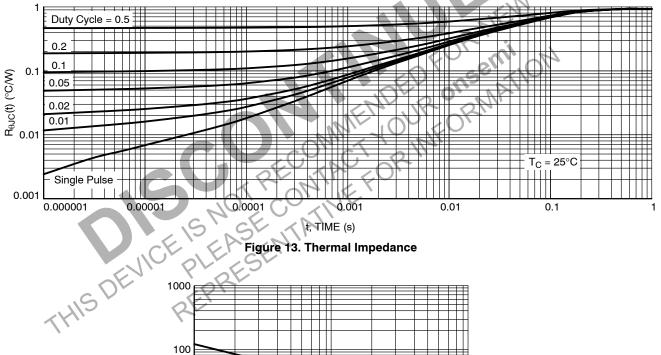


Figure 13. Thermal Impedance

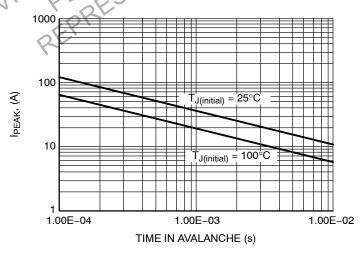


Figure 14. Avalanche Characteristics





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N** 

# **DATE 25 JUN 2018**

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
θ	0 °		12 °		

#### **GENERIC MARKING DIAGRAM\***

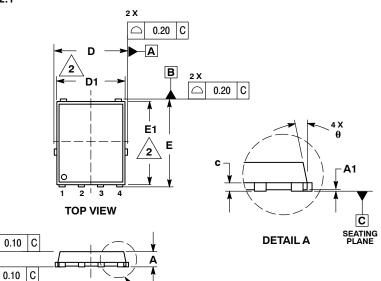


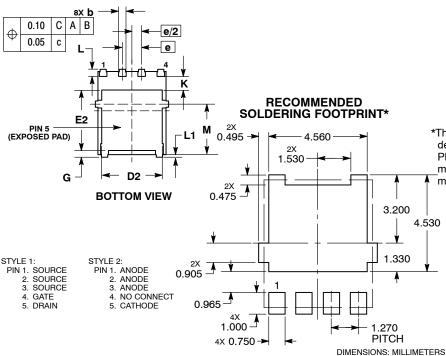
XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL** A

SIDE VIEW

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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ſ	DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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